

# LIST OF ART CITED BY APPLICANT

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 APPLN. SERIAL NO.  
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 APPLICANT(S)  
**Young Wook LEE**

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 GROUP  
**2615**

### U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCL ASS	FILING DATE

### U.S. PATENT APPLICATION PUBLICATIONS

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCL ASS	

### U.S. PATENT APPLICATIONS

	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCL ASS	

### FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCL ASS	Translation	
						Yes	No
	08-272655	10-18-2006	Japan (full Japanese text and English abstract)			Abstract	
	2002-0061288	07-24-2002	Korea (full Korean text and English abstract)			Abstract	

### OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

	Korean Office Action dated April 24, 2009.

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.